

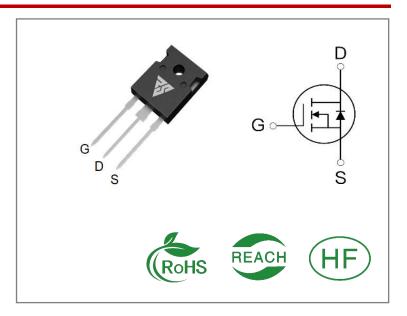
ID	R <sub>DS</sub> (ON)(Typ)	VDSS
28A	0.14Ω	500V

# **Applications:**

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

#### **Features:**

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



## **Ordering Information**

Part Number	Package	Marking	Packing	Qty.
RS28N50W	T0-247-3	RS28N50W	Tube	30 PCS

## Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS28N50W	Units
VDSS	Drain-to-Source Voltage	500	V
ID	Continuous Drain Current TC=25℃	28	
ID	Continuous Drain Current TC=100℃	15	А
IDM	Pulsed Drain Current (Note*1)	112	
PD	Power Dissipation	205	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH,,VDD = 50V, RG = 25 Ω	1120	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260 °C	
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

<sup>\*</sup> Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



#### **Thermal Resistance**

Symbol	Parameter	RS28N50W	Units	Test Conditions
RθJC	Junction-to-Case	0.6	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

## **OFF Characteristics** TJ= 25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	500			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=500V,VGS= 0V
IGSS	Gate- to- Source Forward Leakage			100	- A	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

# ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.14	0.18	Ω	VGS=10V,ID=14A
VGS(TH	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=25 0μA

# Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		25			
trise	Rise Time		200		6	VDS=250V
td(OFF)	Turn- OFF Delay Time		225		nS	ID=28A RG=25Ω
tfall	Fall Time		40			



**Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		3960			VGS=0V
Coss	Output Capacitance		480		рF	VDS=25V
Crss	Reverse Transfer Capacitance		48			f=1.0MHz
Qg	Total Gate Charge		122			VDS=400V
Qgs	Gate- to- Source Charge		18		nC	ID=28A
Qgd	Gate-to-Drain(" Miller") Charge		61			VGS=10V

#### **Source-Drain Diode Characteristics**

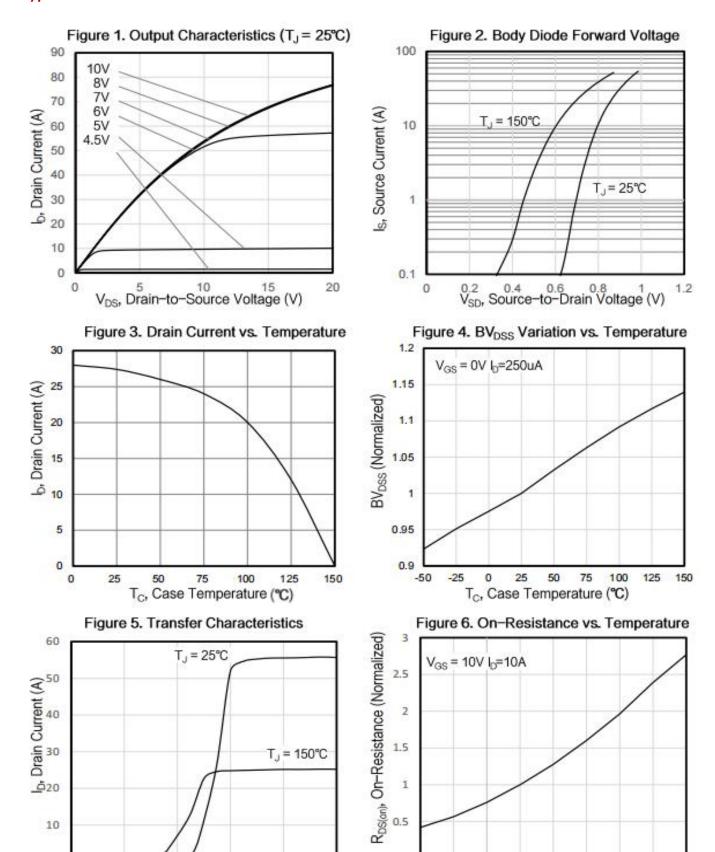
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			28	Α	Integral pn- diode
ISM	Maximum Pulsed Current			112	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=14A,VGS=0V
trr	Reverse Recovery Time		498		nS	VGS=0V
Qrr	Reverse Recovery Charge		9.4		μC	IS=14A,di/dt=100 A/μs

#### Notes:

- \* 1. Repetitive rating, pulse width limited by maximum junction temperature.
- \* 2. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



#### **Typical Feature Curve**



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0

V<sub>GS</sub>, Gate-to-Source Voltage (V)

0

-25

-50

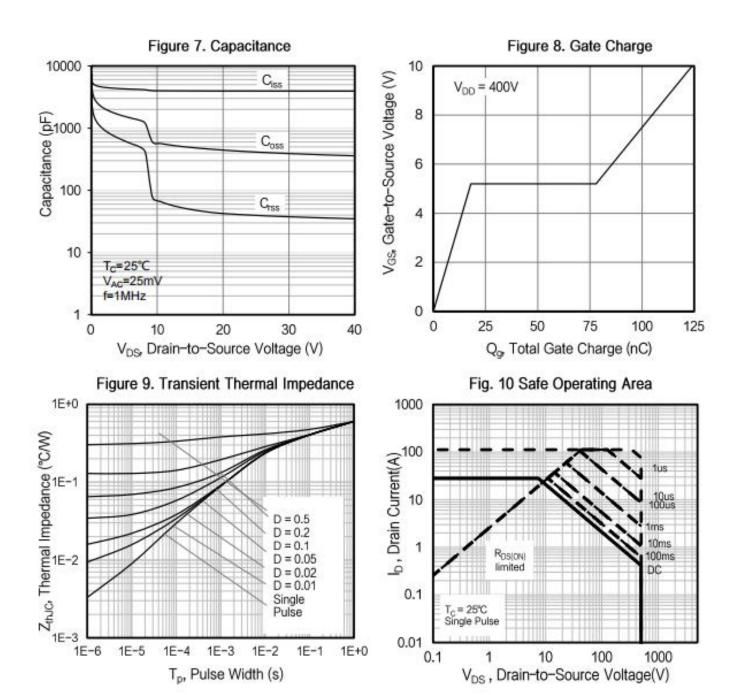
10

75

T<sub>J</sub>, Junction Temperature (°C)

100







## **Test Circuits and Waveforms**

Figure A: Gate Charge Test Circuit and Waveform

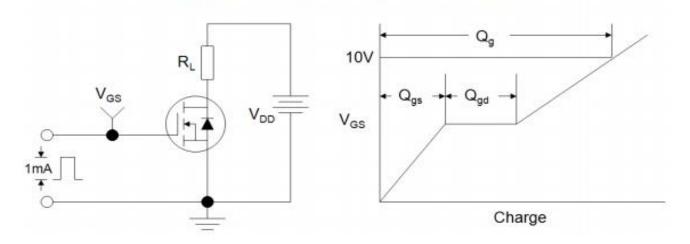


Figure B: Resistive Switching Test Circuit and Waveform

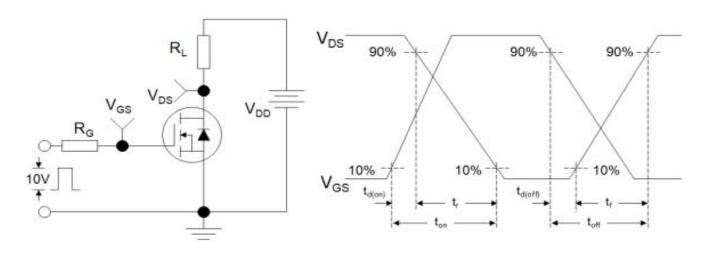
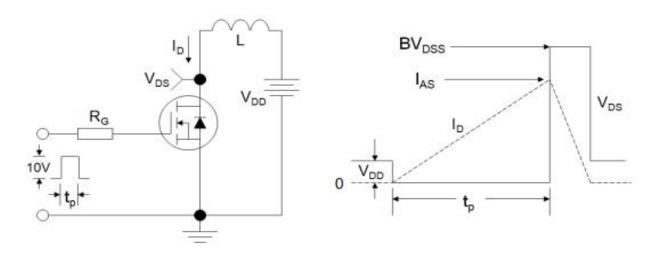
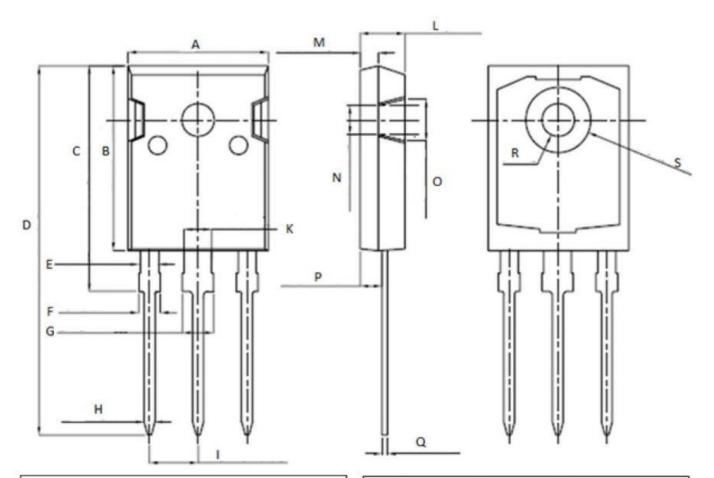


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





# Package outline drawing(TO-247 Unit: mm)



	Unit: mm						
Symbol	Min.	Max.					
Α	15. 95	16. 25					
В	20.85	21. 25					
C	20.95	21. 35					
D	40.5	40.9					
E	1.9	2. 1					
F	2. 1	2. 25					
G	3. 1	3. 25					
Н	1.1	1.3					
1	5. 40	5. 50					

	Unit: mm					
Symbol	Min.	Max.				
K	2.90	3. 10				
L	4. 90	5. 30				
M	1.90	2.10				
N	4.50	4. 70				
0	5. 40	5. 60				
P	2. 29	2.49				
Q	0.51	0. 71				
R	ф3.5	ф3.7				
S	ф7.1	ф 7. 3				



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